

General Description

The WSP4407 is the highest performance trench P-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSP4407 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Product Summery

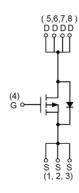
BVDSS	RDSON	ID
-30V	9.6mΩ	-13A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOP-8 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter Rating		Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ -10V ¹	-13	Α
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-10.5	А
I _{DM}	300uS Pulsed Drain Current ²	-60	А
EAS	Single Pulse Avalanche Energy ³	101	mJ
I _{AS}	Avalanche Current	-26	Α
P _D @T _A =25℃	Total Power Dissipation⁴	3.1	W
T _{STG}	Storage Temperature Range -55 to 150		$^{\circ}\! \mathbb{C}$
T_J	Operating Junction Temperature Range -55 to 150		$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-Ambient ¹		75	°C/W
R ₀ JC	Thermal Resistance Junction-Case ¹		24	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25℃, I _D =-1mA		-0.018		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-13A		9.6	12	0
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-5A		15	21	mΩ
V _{GS(th)}	Gate Threshold Voltage)/ -\/ - 250::A	-1.5	-2.0	-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$		5.04		mV/℃
	Drain Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			-1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =55℃			-5	∙ uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-10A		18		S
Q_g	Total Gate Charge (-4.5V)	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-13A		31		
Q_gs	Gate-Source Charge			4.3		nC
Q_gd	Gate-Drain Charge			10		
T _{d(on)}	Turn-On Delay Time			13		
T _r	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_G =6 Ω ,		15		
$T_{d(off)}$	Turn-Off Delay Time	I_D =-1A ,RL=15Ω		50		ns
T _f	Fall Time			29		
C _{iss}	Input Capacitance			1550	1655	
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		315	425	pF
C _{rss}	Reverse Transfer Capacitance			245	345	

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =-25V , L=0.5mH , I _{AS} =-26A	98			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			-4.0	Α
I _{SM}	Pulsed Source Current ^{2,6}				-60	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25℃			-1.1	V
t _{rr}	Reverse Recovery Time	IF=-13A,dI/dt=100A/μs,T _J =25℃		22		nS
Q_{rr}	Reverse Recovery Charge			15		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The EAS data shows Max. rating . The test condition is VDD=-25V,VGS=-10V,L=0.5mH,IAS=-26A
- 4. The power dissipation is limited by 150 ℃ junction temperature
- 5.The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

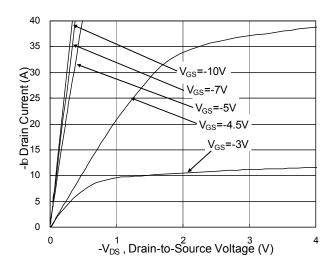


Fig.1 Typical Output Characteristics

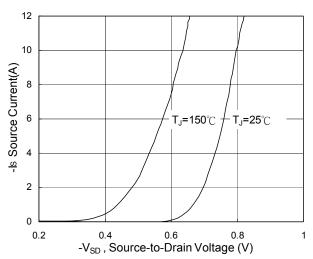


Fig.3 Forward Characteristics Of Reverse

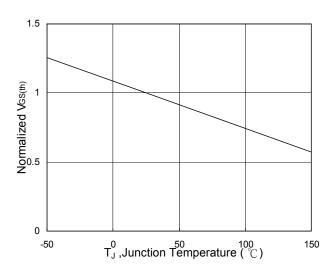


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

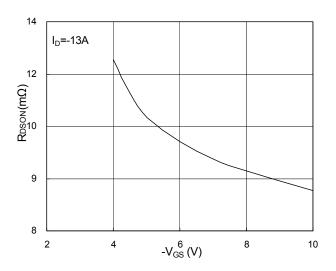


Fig.2 On-Resistance v.s Gate-Source

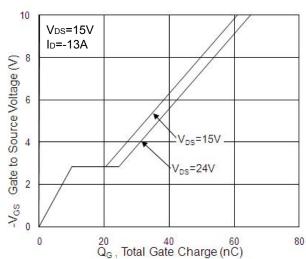
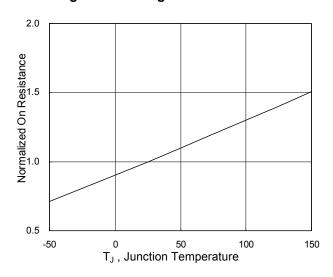


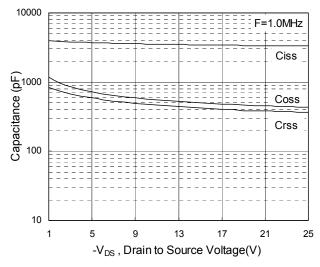
Fig.4 Gate-Charge Characteristics



(°C) Fig.6 Normalized R_{DSON}

vs. T_J





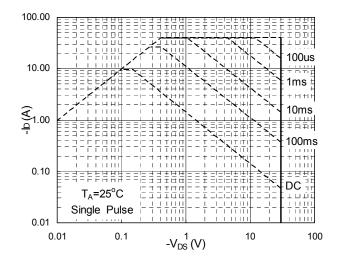


Fig.7 Capacitance

Fig.8 Safe Operating Area

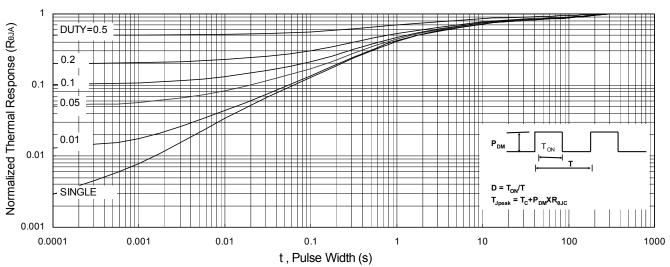


Fig.9 Normalized Maximum Transient Thermal Impedance

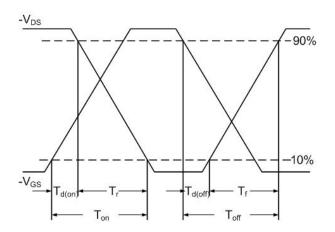


Fig.10 Switching Time Waveform

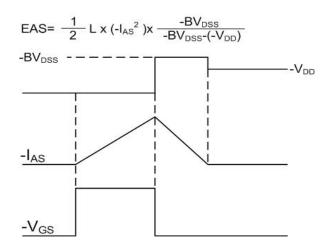


Fig.11 Unclamped Inductive Switching Waveform



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